

U.S. Patent or Published Documents

| Examiner | | | | | | Sub- | Filing |
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| Initial | No. | Patent No. | Date | Patentee | Class | Class | Date |
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Foreign Patent or Published Foreign Patent Application

| Examiner | | Document No. | Publication | Country or | · · · · · · | Sub- | | slation |
|----------|-----|--------------|-------------|---------------|-------------|-------|-----|---------|
| Initial | No. | | Date | Patent Office | Class | class | Yes | No |
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Other Documents

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| Examiner | · · · <u>-</u> · · · · · · · · · · · · · · · · · · · | Date Considered |
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| Examine | /Li Liu | Date Considered 07/07/2006 |
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Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.